Unit: mm

# AN1101SSM

### CMOS single power supply

#### Overview

AN1101SSM is an operational amplifier with a single power supply by CMOS diffusion process.

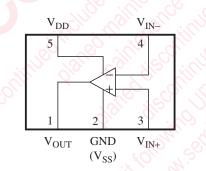
It has low current-consumption compared to general purpose operational amplifier by bipolar diffusion process. 0 V to  $V_{DD}$  is available for both input voltage and output voltage. And this IC is widely applicable to the buttery-driven equipment and to many amplifier circuits which adopt small package products.

#### Features

- Low current-consumption:  $I_{DD} = 55 \,\mu A$  (typ.),  $V_{DD} = 3 \,V$
- Operating input/output voltage range: 0 V to  $V_{DD}$
- Small offset voltage: 0.5 mV (typ.)
- Small input bias current: 1 pA (typ.)
- Operating supply voltage range:
  - 2.5 V to 5.5 V or  $\pm 1.25$  V to  $\pm 2.75$  V

#### Applications

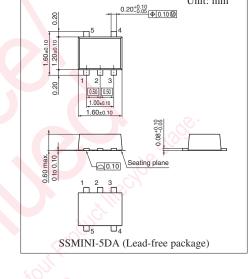
- Various small-size general consumer electronics equipment
- Block Diagram



#### Pin Descriptions

Pin No.	Symbol	Description
1	V <sub>OUT</sub>	Output
2	GND (V <sub>SS</sub> )	Ground, $V_{SS}$ (negative supply) at using two power supply
3	V <sub>IN+</sub>	Input (positive)
4	V <sub>IN-</sub>	Input (negative)
5	V <sub>DD</sub>	Power supply

Note) The AN1101SSM has been designed for general consumer electronics equipment, not for the specific one requiring such a high reliability that may prevent it from threatening the human lives.



#### Absolute Maximum Ratings

Parameter	Symbol	Rating	Unit
Supply voltage	V <sub>DD</sub>	5.6	V
Differential input voltage	DV <sub>IN</sub>	±5.6	V
Input voltage	V <sub>IN</sub>	V <sub>SS</sub> to V <sub>DD</sub>	V
Supply current	I <sub>DD</sub>	_	mA
Power dissipation *2	PD	50	mW
Operating ambient temperature *1	T <sub>opr</sub>	-30 to +85	°C
Storage temperature *1	T <sub>stg</sub>	-55 to +125	°C

Note) 1. \*1: Except for the operating ambient temperature and storage temperature, all ratings are for  $T_a = 25^{\circ}C$ .

\*2: The value at  $T_a = +85^{\circ}C$ .

2. This IC is not suitable for car electrical equipment.

#### Recommended Operating Range

Parameter	Symbol	Range	Unit
Supply voltage	V <sub>DD</sub>	2.5 to 5.5	V
		±1.25 to ±2.75	

Electrical Characteristics at $V_{DD} = 3.0 V$ , $V_{SS} = GND$ , $T_a = 25^{\circ}C \pm 2^{\circ}C$						
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Input offset voltage	V <sub>IO</sub>	Buffer circuit	<u>8</u>	0.5	5.5	mV
Common-mode input voltage	CMV <sub>IN</sub>	$R_{S} = 10 \text{ k}\Omega, R_{F} = 10 \text{ k}\Omega$	0	à.	- 3	V
Open-loop gain	GV	f = 100 Hz	60	90	$\mathcal{O}_{\mathcal{O}}$	dB
Maximum output amplitude voltage 1	V <sub>OH</sub>	$R_L \ge 10 \text{ k}\Omega$	2.90	2.98	—	V
Maximum output amplitude voltage 2	VOL	$R_L \ge 10 \text{ k}\Omega$		0.01	0.05	V
Common-mode input voltage rejection ratio	CMRR	$V_{IN} = 0.0 \text{ V to } 3.0 \text{ V}, R_S = R_F = 10 \text{ k}\Omega$	50	65		dB
Supply voltage ripple rejection ratio *	SVRR	$V_{DD} = 2.5 \text{ V to } 5.5 \text{ V}$	55	70	_	dB
Supply current	I <sub>DD</sub>	No load		55	100	μA

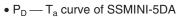
Note) \* : Except for the supply voltage ripple rejection ratio (SVRR),  $V_{DD} = 3 V$ .

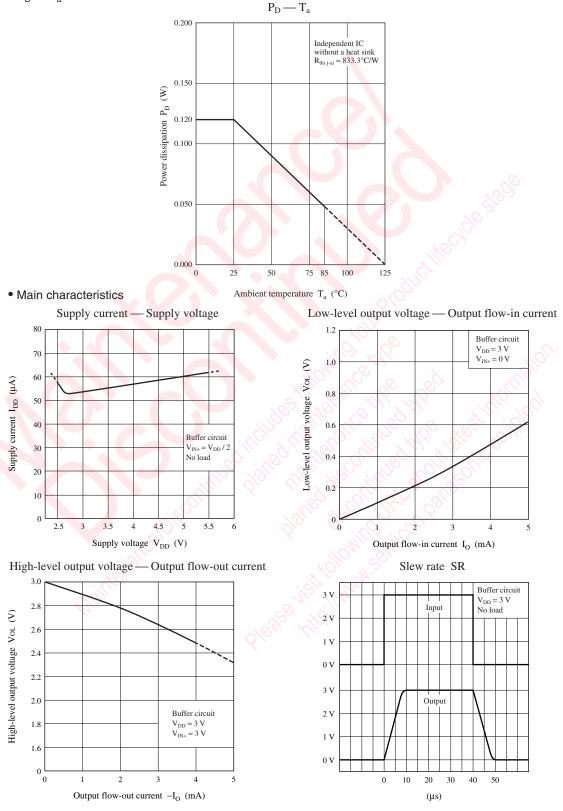
#### • Design reference data

Note) The characteristics listed below are theoretical values based on the IC design and are not guaranteed.

Parameter	Symbol	Conditions	Reference	Unit
Offset current	I <sub>O</sub>	—	1	pА
Input bias current	I <sub>IO</sub>	_	1	pА
Slew rate	SR	$R_L \ge 10 \text{ k}\Omega$	0.35	V/µs
Zero-cross frequency	f <sub>T</sub>	$A_V = 1$	0.8	MHz

#### Technical Data

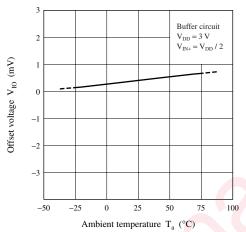




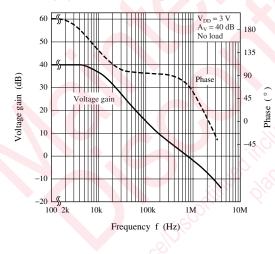
#### Technical Data (continued)

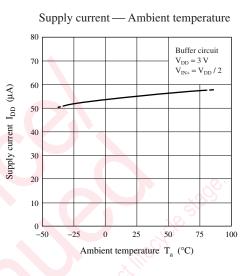
Main characteristics (continued)

Offset voltage - Ambient temperature

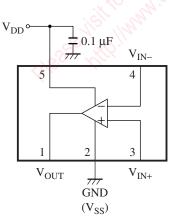


Voltage gain · Phase — Frequency characteristics





Application Circuit Example



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